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Form PTO-1449 (modified)
List of Patents and Publications
For Applicant's Information
Disclosure Statement
(Use several sheets if necessary)

ATTY. DOCKET NO: 5150-61801

SERIAL NO: 10/080,017

APPLICANT: Nair et al.

FILING DATE: February 19, 2002

GROUP: 2863

U.S. PATENT DOCUMENTS

EXAM. INITIALS	REF. DES	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
XS	A1	6,401,220	06/04/2002	Grey et al.			
	A2	5,911,070	06/08/1999	Solton et al.			
	A3	5,940,296	08/17/1999	Meyer			
	A4	5,481,712	01/02/1996	Silver et al.			
	A5	6,094,526	07/25/2000	Marrion Jr. et al.			
	A6	4,831,580	05/1989	Yamada, Yoshikiyo			
	A7	5,005,119	04/1991	Rumbaugh et al.			
	A8	6,061,602	05/2000	Meyer, Frank			
	A9	6,167,562	12/2000	Kaneko, Hiroshi			
	A10	6,226,783	05/2001	Limondin et al.			
V	A11	6,298,474	10/2001	Blowers et al.			

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

XS	A12	Optilab "Image Processing and Analysis Software for the Apple Macintosh™ II, User's Manual, dated 1990.
	A13	MacUser, John Rizzo, Image Analyst and Enhance, July 1990, pp. 55-58.
	A14	SPIE - The International Society for Optical Engineering, Steven Rosenthal and Larry Stahlberg, "Integrated Approach to Machine Vision Application Development", Volume 1386, November 8, 1990, pp. 158-162.
	A15	Automatix News Release, www.applefritter.com/macclones/automatix/newsrelease , "Vision for Process Feedback and Control, 07/03/2000, pp 1-3.
	A16	IPLab, Serious Image Processing for the Macintosh II, 1990.
	A17	SPIE - The International Society for Optical Engineering, Michael S. Mort and Robert J. Fontana, "Low Cost Image Analysis Workstation Which is Menu Driven and Extensible," Volume 1232, February 4, 1990, pp. 380-389.
	A18	IPLab™, User's Guide, Signal Analytics Corporation, 1991.
	A19	MacGuide Magazine, Volume 2, Issue 4, Stuart Gitlow, M.D., "X-Ray Vision," June 1989, pp. 89-94.
	A20	Ric Ford, Optimage Processes Scientific Images, 1994.
XS	A21	Signal Analytics Corp., News Release, "Signal Analytics Brings Powerful Scientific Image Processing to the Macintosh II", February 1, 1990 (2 pgs.).

EXAMINER: *Wing Sun*DATE CONSIDERED: *10/15/03*

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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

XS	A22	IPLab, "Serious Scientific Image Processing for the Macintosh II", 1992 (4 pgs.).
	A23	IPLab, "Gives You Unparalleled Value", 1992, (6 pgs.).
	A24	Signal Analytics Corp., "IPLab Brings Affordable Scientific Image Processing to the Macintosh II", estimated 1990 (2 pgs.).
	A25	Automatix Inc., "A Seminar on Machine Vision & Image Analysis", 1993, (46 pgs.).
	A26	National Instruments, Measurement and Automation Catalogue, Interactive Vision Software, 1999, pp. 518-520.
	A27	MacUser, "Ultimage and IPLab Spectrum", July 1991, (5 pgs.).
	A28	Advanced Imaging, Special Report: Imaging and the Macintosh/Robust Image Databases, April 1991, pp. 18-32.
	A29	"IMAQ Vision Builder Tutorial," National Instruments, January 1999.
	A30	Hunt, Neil, "IDF: A graphical dataflow programming language for image processing and computer vision", p. 351-360, IEEE 1990, retrieved from the IEEE database 1/07/2003.
	A31	Keddy, W.A., Agathoklis, P., "DEDIP: A user-friendly environment for digital image processing algorithm development", p. 733-736, IEEE 1991, retrieved from the IEEE database 1/07/2003.
↓	A32	Konstantinides, Konstantinos, Rasure, John R., "The Khoros Software Development Environment for Image and Signal Processing", p. 1-14, 1992, retrieved from http://www.hpl.hp.com/techreports/92/HPL-92-96.pdf on 01/07/2003.
XS	A33	Sim, Young-Seok, Lim, Chae-Seong, Moon, Young-Shik, Park, Sung-Han, "Design and Implementation of the Visual Programming Environment for the Distributed Image Processing", p. 149-152, IEEE 1996, retrieved from IEEE database 01/07/2003.

EXAMINER: *Ning*

DATE CONSIDERED: 10/16/03

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the patent owner.

Information Disclosure Statement--PTO 1449 (modified)

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